



LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO. 11281-024-999	APPLICATION NO. 10/786,821
	APPLICANT Young-Sun Kim et al.	
	FILING DATE February 25, 2004	ART UNIT 2874

U.S. PATENT DOCUMENTS

*Examiner Initials		Document Number	Date mm/dd/yy	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
IGU	A01	US 5,103,304	04/07/92	Stanley P. Turcheck	
	A02				
	A03				
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FOREIGN PATENT DOCUMENTS

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ART UNIT

2874

NON PATENT LITERATURE DOCUMENTS

*Examiner Initials		Include name of the author (in CAPITAL LETTERS), (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T
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